

3226 mΩ HiTESTER



SPECIFICATIONS

Measurement ranges : 30m/300m/3/30/300/3k/30kΩ
Accuracy : ±0.1%rdg. ±6dgt.(30m to 3Ω ranges)
±0.1%rdg. ±4dgt.(30 to 30kΩ)
Note; When the sampling rate is Fast,
add ±3dgt. to the accuracy of dgt.

Maximum applied
measurement voltage : 3.5mV to 350mV DC
Display : 3500 LCD
Measurement method : 4-terminal method
Sample rate : Slow - 2.5 times/s
Fast - 20 times/s

Open-circuit
terminal voltage : Max. 5V
Comparator : Hi or Lo setting (0 to 3500 counts)
Setting with REF/%(1 to 3500 counts) (0.1
to 99.9%)

High Speed Sampling at 20S/s.

- Wide dynamic range(max. 3500)/10μΩ
- Response time of 150ms (approx.)
- Comparator function
 - High/low setting
 - REF/% setting
- BCD output/data output of the comparator results
- Temperature correction(T.C.) function

Interfaces : Output interface; BCD output of measurement data, comparator results, end of conversion, deviation rate (%) from a reference value
Input interface; Measurement trigger, comparator ON/OFF, external control of zero point adjustment

Auxiliary functions : Temperature correction function, temperature measurement function, filter function hold function

Power supply : R6P×4 or AC adaptor(6V-300mA)
Dimensions : 215W×60H×220Dmm•950g
Accessories : 9287 clip type leads(1), TC adaptor(1)